imall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832 Email & Skype: info@chipsmall.com Web: www.chipsmall.com Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China





FEATURES

•

- 8192 x 8 bit static CMOS RAM
- 70 ns Access Times
- Common data inputs and outputs
- Three-state outputs
- Typ. operating supply current

 70 ns: 10 mA
- Standby current:
 - \circ < 2 μ A at Ta \leq 70 °C
- Data retention current at 2 V:
 o < 1 μ A at Ta ≤ 70 °C</p>
 - TTL/CMOS-compatible
- Automatic reduction of power dissipation in long Read or Write cycles
- Power supply voltage 5 V
- Operating temperature ranges:
 - \circ 0 to 70 $^{\circ}$ C
 - \circ $\,$ -40 to 85 $^\circ\,$ C
- ESD protection > 2000 V (MIL STD 883C M3015.7)
- Latch-up immunity > 100 mA
- Packages: PDIP28 (600 mil) SOP28 (330 mil)

DESCRIPTION

The AS6C6264A is a static RAM manufactured using a CMOS process technology with the following operating modes: - Read - Standby - Write - Data Retention The memory array is based on a 6transistor cell.

The circuit is activated by the rising edge of E2 (at E1 = L), or the falling edge of E1 (at E2 = H). The address and control inputs open simultaneously. According to the information of W and G, the data inputs, or outputs, are active. In a Read cycle, the data outputs are activated by the falling edge of G, afterwards the data word read will be available at the outputs DQ0 -DQ7. After the address change, the data outputs go High-Z until the new read information is available. The data outputs have no preferred state. If the memory is driven by CMOS levels in the active state, and if there is no change of the address,

data input and control signals W or G, the operating current (at IO = 0 mA) drops to the value of the operating current in the Standby mode. The Read cycle is finished by the falling edge of E2 or W, or by the rising edge of E1, respectively.

Data retention is guaranteed down to 2 V. With the exception of E2, all inputs consist of NOR gates, so that no pull-up/pull-down resistors are required. This gate circuit allows to achieve low power standby requirements by activation with TTLlevels too.

If the circuit is inactivated by E2 = L, the standby current

PIN CONFIGURATION



PIN DESCRIPTION

Signal Name	Signal Description
A0 - A12	Address Inputs
DQ0 - DQ7	Data In/Out
E1	Chip Enable 1
E2	Chip Enable 2
G	Output Enable
W	Write Enable
VCC	Power Supply Voltage
VSS	Ground
n.c.	not connected



BLOCK DIAGRAM



TRUTH TABLE

Operating Mode	E1	E2	W	G	DQ0 - DQ7	
Standby/not selected		L	1		High-Z	
	н	•		•	High-Z	
Internal Read	L	н	н	н	High-Z	
Read	L	н	н	L .	Data Outputs Low-Z	
Write	L	н	L		Data Inputs High-Z	

+ H or L



CHARACTERISTICS

All voltages are referenced to VSS = 0 V (ground).

All characteristics are valid in the power supply voltage range and in the operating temperature range specified. Dynamic measurements are based on a rise and fall time of ≤ 5 ns, measured between 10 % and 90 % of VI, as well as input levels of VIL = 0 V and VIH = 3 V. The timing reference level of all input and output signals is 1.5 V, with the exception of the tdis-times, in which cases transition is measured \geq 200 mV from steady-state voltage.

Absolute Maximum Ratings ^a		Symbol	Min.	Max.	Unit
Power Supply Voltage		Vcc	V _{CC} -0.3	7	V
Input Voltage		Vi	-0.3	Vcc + 0.5 b	V
Output Voltage		Vo	-0.3	V _{CC} + 0.5 ^b	V
Power Dissipation		Po		1	W
Operating Temperature	C-Type I-Type	Ta	0 -40	70 85	°C °C
Storage Temperature	C/I-Type	T _{stg}	-55	125	°C
Output Short-Circuit Curren at V _{CC} = 5 V and V _O = 0 V ^c		I _{os}		100	mA

- a. Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only, and functional operation of the device at condition above those indicated in the operational sections of this specification is not implied.Exposure to absolute maximum rating conditions for extended periods may affect reliability
- b. Maximum voltage is 7 V
- c. Not more than 1 output should be shorted at the same time. Duration of the short circuit should not exceed 30 s.

Recommended Operating Conditions	Symbol	Conditions	Min.	Max.	Unit
Power Supply Voltage	Vcc		4.5	5.5	V
Data Retention Voltage	V _{CC(DR)}		2.0		V
Input Low Voltage ^d	VIL		-0.3	0.8	V
Input High Voltage	VIH		2.2	V _{CC} + 0.3	V

d -2 V at Pulse Width 10 ns



Electrical Characteristics	Symbol	mbol Conditions		Min.	Max.	Unit
Supply Current - Operating Mode	ICC(OP)	Vcc Vil Vil tw	= 5.5 V = 0.8 V = 2.2 V = 70 ns		55	mA
Supply Current - Standby Mode (CMOS level)	Icc(sa)	V _{CC} V _{ET} = V _{E2} or V _{E2} C-Type I-Type	= 5.5 V = V _{CC} - 0.2 V = 0.2 V		2 5	μА μА
Supply Current - Standby Mode (TTL level)	I _{CC(SB)} 1	$V_{CC} \ V_{\overline{E1}} = V_{E2}$ or V_{E2}	= 5.5 V = 2.2 V = 0.8 V		3	mA
Supply Current - Data Retention Mode	ICC(DR)	V _{OC(DR)} V _{ET} = V _{E2} or V _{E2} C-Type I-Type	= 2V = V _{CC(DR)} - 0.2 V = 0.2 V		1 3	μА 4
Output High Voltage Output Low Voltage	V _{OH} V _{OL}	Voc Ion Voc IoL	= 4.5 ∨ = -1.0 mA = 4.5 ∨ = 3.2 mA	2.4	0.4	v v
Output High Current Output Low Current	¹ он I _{OL}	Vcc VoH Vcc VoL	= 4.5 V = 2.4 V = 4.5 V = 0.4 V	3.2	-1	mA mA
Input Leakage Current High	lar	Voc V _{IH} C/I-Type	= 5.5 V = 5.5 V		1	μА
Low	lıı,	V _{CC} V _{IL} C/I-Type	= 5.5 ∨ = 0 ∨	-1	÷.	μА
Output Leakage Current High at Three-State Outputs	Чонд	V _{CC} V _{OH} C/I-Type	= 5.5 ∨ = 5.5 ∨	×	,	μΑ
Low at Three-State Outputs	locz	V _{CC} V _{OL} C/I-Type	= 5.5 V = 0 V	-1		μА



Syn	nbol			
Alt	IEC	Min.	Max.	Unit
42	t _{t(QXI)}	5	10	ns
t _{wc} t _{RC}	t _{ew} t _{eR}	70 70		ns ns
t _{ace} t _{oe} t _{aa}	l _{acE)} l _{a(G)} l _{a(A)}		70 40 70	ns ns ns
t _{wP} t _{CW}	t _{w(W)} t _{w(E)}	50 65		ns ns
tas t _{cw} t _{WP} t _{DS}	t _{eu(A)} t _{eu(E)} t _{eu(W)} t _{eu(D)}	0 65 50 35		ns ns ns
юн taн	t _{n(D)} t _{h(A)}	0 0		ns ns
L _{OM}	L _{V(A)}	5		ns
t _{HZCE} tHZWE	t _{dis(E)} t _{dis(W)}	0	25 30	ns ns ns
	Alt L2 L2 LXCE LACE LACE LACE LACE LACE LACE LACE LA	L2 L(QX) L2 L(QX) LWC LeW LRC LeW LACE LeE) LACE LeE)	Alt. IEC Min. 1/2 1/(QX) 5 1/2 1/(QX) 70 1/(QC) 1/(QX) 70 1/(QC) 1/(QX) - 1/(QC) 1/(Q(X)) - 1/(QX) 1/(Q(X)) 50 1/(QX) 1/(QX) 0 1/(QX) 1/(QX) 0	Alt. IEC Min. Max. t_{L2} $t_{I(QX)}$ 5 10 t_{WC} t_{WW} t_{WW} 70 10 t_{WC} t_{WR} T_0 70 10 t_{WC} t_{WH} T_0 70 10 t_{WE} t_{WR} 70 70 10 t_{ACE} $t_{A(H)}$ - 70 40 t_{AA} $t_{A(A)}$ - 70 40 t_{AA} $t_{A(A)}$ - 70 40 t_{WH} $t_{A(A)}$ - 70 70 t_{WH} $t_{A(A)}$ 50 - - - t_{AS} $t_{W(H)}$ 65 - - - - t_{OH} $t_{N(A)}$ 0 - - - - - - - - - - - - - - - - - - -

Data Retention Mode E1-Controlled

Data Retention Mode E2-Controlled



$$\begin{split} & \forall_{E2(DR)} \geq \forall_{CC(DR)} \text{ - } 0.2 \ \forall \ \text{or} \ \forall_{E2(DR)} \leq 0.2 \ \forall \\ & \forall_{CC(DR)} \text{ - } 0.2 \ \forall \leq \forall_{E1(DR)} \leq \forall_{CC(DR)} \text{ + } 0.3 \ \forall \end{split}$$





TEST CONFIGURATION FOR FUNCTIONAL CHECK



* in measurement of t_{dis(E)}, t_{dis(W)}, t_{dis(G)} the capacitance is 5 pF.

Capacitance	Conditions	Symbol	Min.	Max.	Unit
Input Capacitance	V _{OC} = 5.0 V V ₁ = V _{SS}	Ci		8	pF
Output Capacitance	f = 1 MHz T _a = 25 °C	co		10	pF

All pins not under test must be connected with ground by capacitors.





Read Cycle 1 (during Read cycle: $\overline{E1} = \overline{G} = V_{IL}$, $E2 = \overline{W} = V_{IH}$)



Read Cycle 2 (during Read cycle: W = VIH)



Write Cycle 1 (W-controlled)





Write Cycle 2 (E1-controlled)







The information describes the type of component and shall not be considered as assured characteristic. Terms of delivery and rights to change design reserved.



ORDERING INFORMATION

Alliance	Organization	VCC Range	Package	Operating Temp	Speed ns
AS6C6264A-70SCN	8K x 8	4.5 - 5.5V	28pin 330 mil SOP	Commercial~ 0 C – 70 C	70
AS6C6264A-70SIN	8K x 8	4.5 - 5.5V	28pin 330 mil SOP	Industrial ~ -40 C - 85 C	70
AS6C6264A-70PCN	8K x 8	4.5 - 5.5V	28pin 600 mil P-DIP	Commercial~ 0 C – 70 C	70
AS6C6264A-70PIN	8K x 8	4.5 - 5.5V	28pin 600 mil P-DIP	Industrial ~ -40 C - 85 C	70

PART NUMBERING SYSTEM

AS6C	6264	Α	-70	Х	Х	N
SRAM prefix	Device Number: Low Power (64K)	Die Rev	Access Time	Package Option: P=28pin 600mil PDIP S=28pin 330mil SOP	Temperature Range: C = Commercial (0 to 70 C) I = Industrial (-40 to + 85 C)	N = Lead Free RoHS compliant part





Alliance Memory, Inc 511 Taylor Way, San Carlos, CA 94070, USA Phone: 650-610-6800 Fax: 650-620-9211 www.alliancememory.com

Copyright © Alliance Memory All Rights Reserved

© Copyright 2009 Alliance Memory, Inc. All rights reserved. Our three-point logo, our name and Intelliwatt are trademarks or registered trademarks of Alliance. All other brand and product names may be the trademarks of their respective companies. Alliance reserves the right to make changes to this document and its products at any time without notice. Alliance assumes no responsibility for any errors that may appear in this document. The data contained herein represents Alliance's best data and/or estimates at the time of issuance. Alliance reserves the right to change or correct this data at anytime, without notice. If the product described herein is under development, significant changes to these specifications are possible. The information in this product data sheet is intended to be general descriptive information for potential customers and users, and is not intended to operate as, or provide any guarantee or warrantee to any user or customer. Alliance does not assume any responsibility or liability arising out of the application or use of any product described herein, and disclaims any express or implied warranties related to the sale and/or use of Alliance products including liability or warranties related to fitness for a particular purpose, merchantability, or infringement of any intellectual property rights, except as express agreed to in Alliance's Terms and Conditions of Sale (which are available from Alliance does not convey a license under any patent rights, copyrights; mask works rights, trademarks, or any other intellectual property rights of Alliance or third parties. Alliance does not authorize its products for use as critical components in life-supporting systems where a malfunction or failure may reasonably be expected to result in significant injury to the user, and the inclusion of Alliance products in such life-supporting systems implies that the manufacturer assumes all risk of such use and agrees to indemnify Alliance against all claims arising from such use.